| Notice of References Cited | Application/Control No. 10/534,810 | Applicant(s)/Patent Under Reexamination PROIDL ET AL. | | |
|----------------------------|---------------------------------------|---|-------------|--|
| | Examiner | Art Unit | Page 1 of 1 | |
| | Jared Beltowski | 2621 | | |
| II S DATENT DOCUMENTS | | | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| * | Α | US-2002/0068558 | 06-2002 | Janik, Craig M. | 455/422 |
| * | В | US-6,842,460 | 01-2005 | Olkkonen et al. | 370/465 |
| | U | US- | | | |
| | ם | US- | | | |
| | ш | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Ι | US- | | | |
| | - | US- | | | |
| | ٦ | US- | | | |
| | K | US- | | | |
| | ┙ | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Ø | | | | | |
| | R | | | | | |
| | Ø | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | |
|---|---|---|--|
| | C | | |
| | V | | |
| | w | | |
| | х | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.